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# A silicon analyser for the OSIRIS spectrometer: An analytical and Monte Carlo simulation study



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#### ABSTRACT

The indirect time-of-flight near-backscattering spectrometer OSIRIS at the ISIS Facility is being upgraded with the addition of a silicon analyser. The new analyser bank will allow to increase the dynamic range, giving access to relaxation times up to 400 ps, and provide a further dimension in momentum transfer detection with the help of position-sensitive detectors. Here we present analytical calculations for the energy resolution and an extensive Monte Carlo simulation study to assess the performance of the new analyser bank. Simulation and calculation agree perfectly and confirm the initial design parameters of the spectrometer. The simulations predict similar detected intensity but with a higher resolution compared to the existing analyser setup using pyrolytic graphite crystals. Furthermore, the simulations stress the importance of the sample height for this setup and point toward a necessary further upgrade of the guide system. Further improvements of the energy resolution might be achieved with a pulse shaping chopper.

### 1. Introduction

The backscattering technique with neutrons was developed about five decades ago in Garching, Germany [1,2]. This type of instrument promised the highest energy resolution of about 1  $\mu$ eV at that time and hence access to ns relaxation times. Most of the following developments focused on enhancing the flux and, nowadays, the most modern instruments also exploit phase space transformation [3–6].

At pulsed sources, backscattering from an analyser crystal has been implemented in combination with time-of-flight (TOF) to analyse the energy of the incident neutrons. One of the first instruments of this type was IRIS at the ISIS Facility (Rutherford Appleton Laboratory, Didcot, UK) [7,8]. The instrument is different from classical backscattering spectrometers in the sense that it uses cooled pyrolytic graphite analysers in a near-backscattering geometry. This results in a relaxed energy resolution of about 15 µeV, but with a significantly increased dynamic range. The combination of high resolution and wide range in momentum transfers (Q) with a large dynamic range allowed novel applications in cold neutron spectroscopy. Based on a similar design as IRIS, the OSIRIS spectrometer at the ISIS Facility achieved a large gain in intensity by using a supermirror guide and an increased analyser unit [9,10]. At the other end an improvement of the energy resolution towards the µeV regime at a spallation source was achieved on BASIS (Oak Ridge National Laboratory, TN, USA), by combining a long flight

path with a silicon analyser [11]. Following this concept a series of TOF backscattering spectrometers have been built or proposed [12–16]. At reactor sources the approach combining a crystal analyser with a time-of-flight primary spectrometer has been proposed and implemented as well [17–20].

The cold TOF spectrometer OSIRIS has been described in detail in Refs. [9,10,21,22] and hence we will only provide a short overview. OSIRIS has been recently upgraded with a moveable Beryllium filter to remove the second order reflection of the pyrolytic graphite analyser [23], and its energy resolution has been modelled with Monte Carlo simulations [24]. It is mainly used to study low-energy excitations, e.g. the magnetic field dependence of the spin resonance in  $CeCoIn_5$  [25], or spinon confinement in  $Yb_2Pt_2Pb$  [26], and for quasielastic neutron scattering experiments probing stochastic dynamics, e.g. for catalysis [27,28], or the mobility of ions in battery materials [29].

To further improve the performance of the instrument with respect to energy resolution, and allow novel challenging studies of, for instance, ionic diffusion of weakly incoherently scattering ions in battery materials, an upgrade was proposed to implement a Si(111) analyser unit allowing energy resolution down to  $\Delta E \approx 10~\mu eV$  [30]. This silicon analyser (SA) will be constituted of two banks of curved analysers, positioned on the vacant side inside the vacuum tank of the secondary

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spectrometer. Each analyser unit will focus the neutrons onto an image point above or below the sample position. Position-sensitive  $^3$ He detectors (PSD), positioned above and below the horizontal, sample scattering plane  $(Q_x, Q_y)$ , will be used to register the Bragg-reflected neutrons. The use of PSD's allows to access the vertical direction in momentum transfer  $(Q_z)$  for single-crystal studies and gives the opportunity to correct for the small path-length differences in the secondary spectrometer. More details on the engineering design can be found in Ref. [30].

Here we present analytical calculations of the energy resolution and Monte Carlo simulations using the McStas programme package to assess the performance of the new SA setup.

#### 2. Analytical considerations

The OSIRIS instrument has been described in detail previously [9, 10,21,22] and hence we will only provide a brief account of parts relevant for this work. The OSIRIS instrument views the 25 K cold hydrogen moderator at the Target Station 1 of the ISIS Neutron and Muon Source. A curved supermirror guide (m = 2) transports the neutrons to the sample position 34.00 m away from the moderator. At the end of the guide a 1.5 m long focusing guide section (m = 3.6) reduces the beam cross section from  $43 \times 65$  mm to  $22 \times 44$  mm. The secondary spectrometer consists of a large analyser bank and 42 half inch diameter <sup>3</sup>He detectors with an active length of 38 mm. The neutrons are scattered in a near-backscattering geometry from more than  $8000 \times 1 \text{ cm}^2$  sized pyrolytic graphite crystals into the detectors. Two reflections from the graphite crystals can be used: the (002) and (004) reflections define final energies of 1.845 meV and 7.38 meV, respectively. The analyser bank is cooled to 10 K to reduce thermal diffuse scattering.

In a previous study it was shown that the current energy resolution is limited by the geometry of the analyser unit [24]. To further improve the energy resolution, silicon is considered as analyser material, which is the standard at classic backscattering spectrometers, and nowadays also on high-resolution TOF backscattering instruments [31]. There are several advantages in using silicon compared to the present pyrolytic graphite. Since Si(111) has no second order reflection, there is no need for the installation of a cooled beryllium filter. Furthermore, silicon has extremely low thermal diffuse scattering, as it was recently demonstrated by the DNA spectrometer (J-PARC, Naka-gun Ibaraki, Japan) that achieved a very high signal to noise ratio approaching 10<sup>5</sup> [12–14]. However, there is a disadvantage with silicon crystals concerning its neutron reflectivity: the crystals are too perfect for the required resolution, in particular, for the more relaxed resolution in near-backscattering geometry. For the Si(111) reflection, the energy resolution contribution from the Darwin width is 0.077 µeV [31] and, hence, about a factor 100 too small for OSIRIS. That mismatch with the resolution of the primary spectrometer would result in a substantial intensity loss. To overcome this limitation, standard practice involves the elastic deformation of the crystals, which increases the reflected intensity. This results in a gradient in lattice spacing, d, which depends on the curvature radius of the analysers,  $R_A$ , and the thickness of the wafers, D, according to Eq. (1) [3], with  $\mu_{eff}$  being an average Poisson ratio, and the small contribution from the Darwin width being omitted.

$$\frac{\Delta d}{d} = \mu_{eff} \frac{D}{R_A} \tag{1}$$

Another advantage of the new setup is that position-sensitive detectors will be used. The existing graphite analyser on OSIRIS focuses all reflected neutrons to the detector position and hence a position-sensitive detector is not useful. On the other hand, the chosen elliptical geometry with a focus point at the detector position has no path-length differences in the secondary spectrometer. However, the SA will focus the neutrons on an image point below or above the sample position

and therefore a linear PSD can analyse  $\mathcal{Q}_z$  and therefore correct for final flight-path differences.

To calculate the expected energy resolution for the SA setup, we are using the same formalism as previously published [16,24]:

$$\frac{\Delta E}{E} = 2\left\{ \left( \frac{\Delta t}{t} \right)^2 + \left( \frac{\Delta L}{L} \right)^2 + \left( \frac{\Delta d}{d} \right)^2 + (\cot \theta \Delta \theta)^2 \right\}^{1/2}$$
 (2)

For monochromatic focusing conditions of a Bragg-reflecting spherically-bent crystal, the focusing distance f is  $f = \frac{R_A}{2} \sin \theta$  with  $\theta$  the Bragg angle, and the object and image distances are equal to 2f [32].

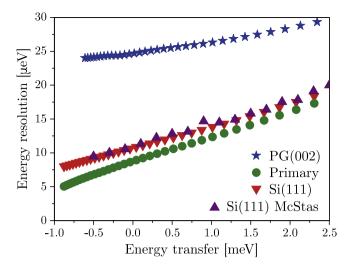
The SA will sit inside the existing vacuum tank at a distance of 880 mm from the sample position. The curvature radius shall be 880 mm and the radius centre point shall be 110 mm below or above the sample. The angular term of the analyser resolution is determined by the near-backscattering Bragg angle  $\theta = 83^{\circ}$ . The Bragg angle is strongly interrelated with the resolution and directly linked to the shift of the focus point. On the other side the Bragg angle has to be balanced with the solid angle opening towards the analyser bank, which determines the intensity. The vertical opening angle towards the analysers from the point of view of the sample position is limited by the positioning of the detectors on a radius of 240 mm around the sample position. The smaller the shift of the focus point, the nearer the detectors will be positioned on the sample plane and, hence, reduce the solid angle available to the analyser crystals, because of shadowing of the scattered neutrons. The 110 mm shift of the radius point was found to be a good compromise between achievable resolution and available solid angle. The divergences are defined through the sample size (assumed to be 10 mm high) and the pixel size of the linear PSD's which will be around 15 mm. This sample size is about the minimum size which is normally applied to single-crystal experiments up to now. More details of the influence of sample size on energy resolution will be presented in the section devoted to the simulations. For a Bragg crystal with incoming beam divergence  $\alpha_i = 1.3^{\circ}$  and outgoing divergence  $\alpha_f = 0.9^{\circ}$  and negligible mosaic spread,  $\Delta\theta$  can be written in the following form [33].

$$\Delta\theta = \frac{\alpha_i \alpha_f}{\sqrt{\alpha_i^2 + \alpha_f^2}} \tag{3}$$

For the contribution of the elastic bending of the wafers, we assume a wafer thickness of D=0.8 mm, which will be the thickness to be used in the construction. With all these input parameters, we calculate the energy resolution around the final energy  $E_f=2.11$  meV.

For the time-of-flight uncertainties  $\Delta t$  the main contribution stems from the moderator pulse, which is about 125  $\mu$ s at  $\lambda = 6$  Å. Interpolated moderator widths determined from diffraction experiments have been used for different wavelengths [24]. Another term is the spread from the guide  $\Delta t_{guide}$ . The latter can be estimated by taking into account path-length differences in the guide (m = 2) with an opening of 43 mm. By calculating the maximum number of reflections over 32 m, about 10, we can estimate the length and therefore the time spread of the neutrons due to different paths. We get a maximum delay of  $\Delta t =$ 22 μs for 6 Å neutrons, from which we deduce a contribution of  $\Delta t_{guide}$  =  $11~\mu s$  to the spread in time. For the sample size TOF contribution we assume a diameter of 10 mm for the sample which can be transferred into a time spread of 8 µs. On the secondary spectrometer, we assume no further time spread from different path lengths due to the use of PSD's and only a  $\Delta t_{detector} = 7 \, \mu s$  spread from the <sup>3</sup>He detectors. All time-of-flight contributions are added quadratically assuming they are statistically independent.

Fig. 1 shows the resulting energy resolution for energy transfers around the elastic line. The calculated resolution for the PG analyser agrees perfectly with the measured value from a vanadium standard at the elastic line and with Monte Carlo simulations [24]. With the SA, the energy resolution will be 11  $\mu$ eV at the elastic line, hence an improvement by about a factor 2.5. Included is also the contribution solely



**Fig. 1.** Analytically calculated total energy resolution of the SA (inverted triangles) and pyrolytic graphite analyser PG(002) (stars). In addition, the contribution from the primary spectrometer alone is shown (circles). The energy resolution of the SA calculated from the McStas simulations is also shown for comparison (triangles).

from the primary spectrometer, which now dominates the resolution, in contrast to the PG(002) case, where the secondary spectrometer is the major contribution to the energy resolution [24]. The calculated contribution of the secondary spectrometer is  $\Delta E_f = 7.2~\mu \text{eV}$  at the elastic line.

With the SA, in the time domain, relaxation times up to around 400 ps will be accessible and in total about 3 orders in magnitude in relaxation times can be covered over a wide range of wave vectors (Q=0.2–2.0 Å<sup>-1</sup>) in a single setting. This increases the versatility of OSIRIS that will then operate synchronously the PG analyser, the SA, and the diffraction bank.

#### 3. Simulations

The simulations were performed with the McStas ray-tracing package [34–36]. As source we used the *ViewModISISver1* component, which links to a file characterising the 25 K cold hydrogen moderator leading to the OSIRIS and IRIS instruments.

For the transport of neutrons, the <code>guide</code> and the <code>guide\_curved</code> components with the standard reflectivity profile were used, with  $\alpha=6.07$  the linear decrease in reflectivity beyond m=1. The curvature radius of the guide is R=2050 m and corresponds to a characteristic wavelength of  $\lambda\approx 2\pi\sqrt{(2a/R)}/k_\perp=1.92$  Å with  $k_\perp=0.0214$  Å<sup>-1</sup> the maximum wavevector for a m=2 guide and a guide width of a=43 mm. At this characteristic wavelength, the transmission of the curved guide is reduced to 2/3 compared to a straight guide and indicates a lower limit of useful wavelengths. Incoming energies up to about 20 meV and hence energy transfers up to 18 meV can be exploited on OSIRIS, as exemplified on IRIS [37,38]. At the end of the guide a m=3.6 straight focusing section reduces the beam area from  $43\times65$  mm² to  $22\times44$  mm². The guide ends 250 mm before the sample position.

The *incoherent* and the *tunnelling sample* components from McStas are used as samples, which both emulate an isotropic incoherent scatterer either for elastic or inelastic scattering. The sample geometry is defined by a hollow cylinder, with thickness of 2 mm and an outer diameter of 12 mm. The sample height is set as a variable parameter, with a default value of 10 mm.

The SA is modelled using two instances of the *PerfectCrystal* component, representing the top and bottom part of the analyser, respectively, as illustrated in Fig. 2(a). Note that the *PerfectCrystal* component describes a curved crystal on a sphere. The position of the SA is fixed to a distance of 880 mm from the sample. The curvature radius is then

defined as  $R_A = 880 + \Delta R_A$  mm, with  $\Delta R_A$  being the offset leading to under or over-focusing of the sample image.

The height of the SA is set to 413 mm ( $-368 \le y \le 45$  mm with the sample at the origin) for the bottom part and 311 mm ( $55 \le y \le 366$  mm) for the top part, which represent an angular coverage of 40–45° in  $\phi$  (sample-height dependent, blue area in Fig. 2(a)). The analyser width is set to 50 mm, which corresponds to the width of one detector tube at the detector position, and represents 3.25° of the 142.5° angular coverage in  $\theta$ . We only consider one scattering angle in the horizontal plane assuming no significant change of resolution and performance with  $2\theta$ . The reflection condition of the analyser is determined by the Bragg law considering scattering angles close to 83° and the d-spacing of Si(111) lattice planes,  $d_{111} = 3.135$  Å. The spread in d-spacing is determined from Eq. (1), with values close to  $\Delta d/d = 3 \cdot 10^{-4}$ .

The top and bottom detectors are modelled by several superimposed monitor components, including the PSD monitor and the TOF2E monitor components, measuring the 2D spatial distribution and the final energy of neutrons converted from the TOF at the detector position, respectively. Linear position-sensitive <sup>3</sup>He tubes, with 1/2 inch diameter, will be used as detectors. They exhibit a dead end of about 37 mm, which will interfere with the scattered neutrons and has to be taken into account in the simulations. It is not relevant for the resolution considerations, however, the solid angle and therefore the intensity is directly influenced by the detector dead end. The position sensitive aspect of the detector is modelled by dividing the detector height in 10 sections, represented by a stack of 10 monitor components with a pixel height of 15 mm (labelled  $B_{1}$  to  $B_{10}$  and  $T_{1}$  to  $T_{10}) \ and \ a$ width of 12.7 mm. The monitor arrays are positioned on a 240 mm and 290 mm radius from the sample for the bottom and top part, respectively. The larger radius for the top detector array results from engineering constraints around the sample bin of the spectrometer. The detector dead-spot (DS) is simply represented, at the detector position, by an offset of the monitor arrays. The shadow caused by the dead-spot (DS) on the silicon analyser (Fig. 2(b)) is treated by adding a neutronabsorbing mask at the position of the detector, modelled beforehand by a Beamstop component. The neutron counts on each pixel of the top and bottom PSD detectors are shown in Fig. 2(c) and (d). The size of the sample image at the position of the detector depends on the sample height; for a 3 cm tall sample, the entire analyser and detector array is used.

The line shape parameter full width at half maximum (FWHM), which represents the energy resolution and can be directly compared to the analytical calculations, is extracted from the simulated spectra through a fit with a Gaussian line shape. The curve is fitted to the highly asymmetric simulation curves in a restricted energy range around the peak value.

#### 4. Results and discussion

In the following section we will consider the influence of different parts of the instrument to the resolution before we discuss the full results.

#### 4.1. Pixel-wise and overall resolution

Fig. 3 shows the line shape, calculated from the time-of-flights, measured on each pixel constituting the monitor arrays associated to the top and bottom part of the SA. The line shapes are zero-shifted, *i.e.* the energy corresponding to the maximum of the line shape is shifted to zero. Note that only the pixel with neutron counts are represented (cf. Fig. 2(c), (d)). For a specific pixel, the FWHM of the line shape is estimated, from a Gaussian fit, in the range 9.7–11.1  $\mu$ eV. The slightly better resolution of the detector pixels with lower neutron counts (B<sub>2</sub>, B<sub>9</sub>, and T<sub>2</sub>, T<sub>8</sub>) is explained by their partial exposure to the sample images, which makes the effective sample height smaller, thus reducing its contribution to the resolution. We also report in Fig. 3 the sum

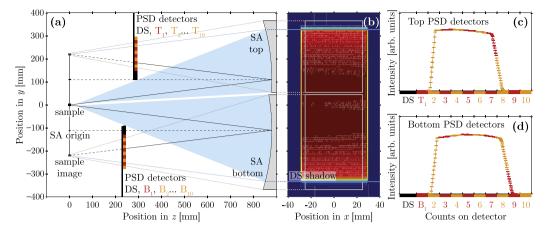


Fig. 2. (a) Scheme of the silicon side of the secondary spectrometer modelled in McStas. (b) Neutron counts on the analyser (2D PSD monitor component). Dimension and position of the SA top and bottom part are represented by grey lines, and detector dead-spot (DS) shadow positions by blue lines. Pixel-wise neutron counts on the PSD top (c) and bottom (d) detectors.

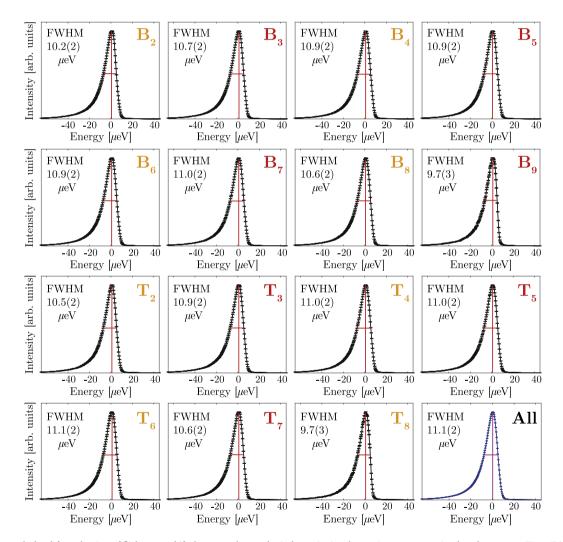


Fig. 3. Line shape, calculated from the time-of-flights, zero-shifted, measured on each pixel constituting the monitor arrays associated to the top part ( $T_2$  to  $T_8$ ) and bottom part ( $B_2$  to  $B_9$ ) of the SA, together with their FWHM. The sum of the 15 individual pixel line shapes is represented in blue (labelled "All") and has a FWHM of 11.1(2)  $\mu$ eV.

of the individual pixels. The overall total energy resolution is about  $11.1(2) \mu eV$  in excellent agreement with the analytical calculations.

In order to isolate the contribution of the SA from the primary spectrometer, we added a <code>DiskChopper</code> component directly after the source component, to reduce the time-of-flight spread from <code>ca</code> 125  $\mu s$  to <code>ca</code> 12  $\mu s$ . Note that the average line shape is now symmetric (Fig. 4),

which confirms that the asymmetry of the total time-of-flight (primary and secondary) originates from the moderator asymmetric pulse. Note that an overall signal to background ratio of more than four orders of magnitude should be possible in such a configuration, a value which has already been demonstrated on the DNA spectrometer. The FWHM of the line shape is 6.0(1) µeV, which then corresponds mostly to the

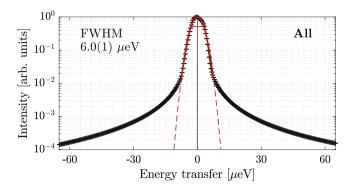


Fig. 4. Simulated line shape on a logarithmic scale, calculated from the sum of the zero-shifted lines over all pixel detectors. The incoming pulse was chopped to a length of  $12~\mu s$ . As a dashed line, a Gaussian fit is included to determine the FWHM.

secondary spectrometer contribution of the total resolution. Adding quadratically this contribution from the secondary spectrometer with the contribution from the primary spectrometer, which was estimated to be 8.5  $\mu eV$  [7], results in a total resolution of 10.4  $\mu eV$  in good agreement with the simulation.

The width of 6.0(1) µeV is then a good prediction for an OSIRIS spectrometer equipped with a pulse shaping chopper. The disadvantage of a pulse shaping chopper option is the drastically reduced dynamic range, reasoned now by the width of the moderator pulse and the distance between chopper and moderator [16]. The dynamic range can be increased by a multi-slit option for the choppers. In combination with phase changes at the chopper system a wide dynamic range can be recovered. That option has been implemented in the DNA spectrometer [12]. The shortening of the pulses and the sequential measuring have a direct impact on the counting rate. With the chosen Bragg angle it would not be possible to achieve an even better energy resolution, for example, comparable to the DNA spectrometer [12]. The small size of the secondary spectrometer limits the possibilities towards an even higher resolution. To achieve an improvement of the energy resolution by a factor 2 with all the implications on operation and intensity of the spectrometer this option seems to be not very favourably. A complete new design would be necessary to move towards 1 µeV resolution, which was already proposed some time ago [16].

#### 4.2. Resolution dependence in relation to SA geometry

Fig. 5 shows the dependence of the intensity (a) and FWHM (b) of the line shape with the vertical distance (offset) of the focus point from the sample (cf. Fig. 2(a)). That offset is directly correlated to the Bragg angle at the SA and therefore to the resolution. With increasing offset also the path length differences play a larger role and hence the resolution worsens with a single detector compared to the pixelated detection mode. The detector dead-spot creates a shadow on the SA and consequently the detected intensity decreases, depending on the offset value. On the other side, the offset value is directly linked to the Bragg angle and hence the resolution. At an offset value of 120 mm the whole SA is exposed to the neutrons. We have chosen a distance of 110 mm (box in Fig. 5) as the most sensible compromise between resolution and solid angle.

Fig. 5(c) shows the dependence of the FWHM with the  $\Delta R_A$  parameter, which represents a modulation of the curvature radius of the SA around its value of 880 mm when keeping the distance between sample axis and analyser constant at 880 mm, *i.e.* having the SA in over-focusing ( $\Delta R_A < 0$ ) or in under-focusing conditions ( $\Delta R_A > 0$ ). The energy resolution shows a broad minimum for values of  $\Delta R_A$  in the range of 0–40 mm.

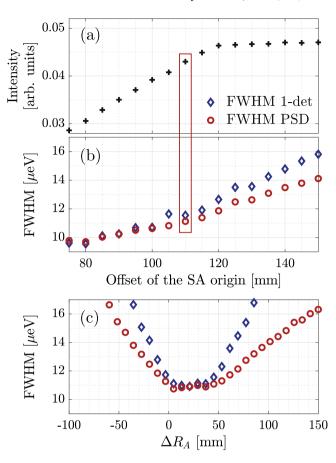


Fig. 5. Dependence of the intensity (a) and FWHM (b) of the line shape with the offset of the SA origin. Included are simulated results from a whole detector tube (diamonds) and from the summed individual pixels (circles). (c) Dependence of the FWHM with the  $\Delta R_A$  parameter.

#### 4.3. Resolution dependence with sample height

Fig. 6 shows the dependence of the intensity and FWHM of the line shape with sample height. As expected, the intensity varies linearly with the sample height. The energy resolution saturates at ca 11  $\mu$ eV for a small sample (h=10 mm) and increases linearly to ca 18  $\mu$ eV for a 30 mm sample. This dependence opens up the possibility to trade intensity against resolution. With a modest increase of the FWHM by 50% the measured intensity can be increased by a factor 3. The resolution of the PG analyser is dominated by the elliptical geometry [24] and, hence, the influence of the sample height is quite small. By eliminating that contribution in the resolution, in Eq. (2), the  $\Delta\theta$  term is now dominated by the divergence contribution from the sample height.

For an ideal reflection the sample size defines the size of the picture on the focus point, which is about 240 mm behind the detectors position. Therefore the vertical Q-direction of a small sample can be resolved on the PSD.

To use the highest resolution without losing too much intensity with a smaller sample an important step would be to focus the neutrons on a smaller sample spot. By using modern guide geometries, like elliptic or parabolic focusing sections, smaller sample spots can be achieved and a gain in intensity of a factor of about 5 on a 1 cm $^2$  sample size are within reach for OSIRIS.

#### 4.4. Resolution dependence with energy transfer

The dependence of the energy resolution with the energy transfer is shown in Fig. 1. The trend calculated from the McStas data is in excellent agreement with the analytical calculation as shown in this figure.

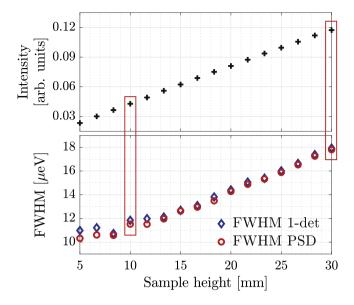
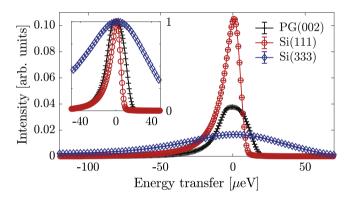


Fig. 6. Dependence of the intensity and FWHM on sample height. Included are simulated results from a whole detector tube (diamonds) and from the summed individual pixels (circles).



**Fig. 7.** Line shape for the PG(002) (crosses), and average line shapes for the SA (top and bottom), considering the (111) reflection (circles) and the (333) reflection (diamonds). Line shapes are normalised to unity in insert.

#### 4.5. Resolution with the Si(333) reflection

The present OSIRIS supermirror guide delivers neutrons up to about 20 meV with high intensity and beyond this energy the cut-off due to the curvature reduces the intensity smoothly. Hence, it will be possible to use the Si(333) reflection with a suitable setting of the bandwidth choppers. That instrument setting could deliver valuable information on a much wider Q-range up to  $Q = 6 \text{ Å}^{-1}$ . A much wider wave vector range is beneficial in studies of local dynamics to properly assess the elastic incoherent structure factor. Also jump diffusion models for translational dynamics rely on a wide-enough Q-range. We also simulated the Si(333) reflection of the SA by decreasing the  $d_{hkl}$  from 3.135 Å to 1.045 Å, and increasing the incident neutron energy from 2.0-2.2 meV to 18.0-19.8 meV. This increases the maximum Q to  $ca 6 \text{ Å}^{-1}$ , at the cost of an increased energy resolution, simulated as FWHM = 77.8(3) µeV at the elastic line (Fig. 7). The final energy of the Si(333) reflection is a factor 9 larger, however, with a smaller wavelength the pulse width from the moderator decreases and therefore the energy resolution is smaller than the factor 9 increase. In fact, the energy resolution is smaller than the presently possible value for the PG(004) setup, which is FWHM = 99  $\mu$ eV with still a smaller *Q*-range.

#### 4.6. Intensity comparison

Finally, we discuss the simulated intensities of the PG(002) analyser and the Si(111) analyser, considering the standard sample height of 10 mm (cf. Fig. 7). Calculating the integral under the spectral curves we obtain a factor 1.8 higher intensity for the SA compared to the PG analyser, which is due to the increased solid angle. That factor does not include the losses due to the transmission of the Beryllium filter on the PG side, about 60% [23]. Hence, it can be expected that, considering the same sample size, the SA setup will outperform the PG analyser not only in the view point of resolution but also intensity. Because the analysing energy of PG(002) and Si(111) are very similar, both analysers, in addition to the diffraction bank, can be operated concurrently for one sample, which significantly increases the output and versatility of OSIRIS.

#### 5. Conclusions

Monte Carlo simulations and analytical calculations have been performed to describe the energy resolution of a new secondary spectrometer of the OSIRIS instrument. The use of silicon analysers will improve the energy resolution by about a factor 2.5 and relaxation times up to 400 ps will be accessible, compared to about 160 ps previously. The predicted FWHMs of the analytical calculations and the results from the simulations are in excellent agreement. The simulations guided the design to choose the optimum geometric parameters, and evinces a strong link between sample height and resolution in this high resolution setup. As a consequence a new focusing guide would benefit this SA setup. Preliminary Monte Carlo simulations estimate a gain in intensity of a factor 5 at the sample position on a 1 cm<sup>2</sup> spot size with an elliptically curved supermirror guide. Due to the larger solid angle, the measured intensity on the SA will be similar to the one obtained on the pyrolytic graphite side. The concurrent use of the PG analyser and the SA will lead to an increase in intensity by about a factor 3 with respect to the graphite analyser alone. The simulations also showed the limitations of this design, which is constrained by the existing design of the secondary spectrometer. Implementation of a pulse shaping chopper would allow to gain another factor 2 in resolution with serious consequences for dynamic range and intensity. However, to go beyond this value, a completely new designed secondary spectrometer is necessary. The OSIRIS silicon analyser is now under construction and envisaged to be ready to the user community in the second half of 2021.

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